



Welcome to [E-XFL.COM](#)

What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Obsolete
Core Processor	C166
Core Size	16-Bit
Speed	20MHz
Connectivity	EBI/EMI, SPI, UART/USART
Peripherals	POR, PWM, WDT
Number of I/O	77
Program Memory Size	-
Program Memory Type	ROMless
EEPROM Size	-
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	-
Oscillator Type	External
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	PG-TQFP-100
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/c165lf3vhafxuma1

Revision History: 2000-12

V2.0

Previous Version:	1998-12	Update 0.5μ technology
	01.96	3 Volt Addendum
	07.95	25 MHz Addendum
	09.94	Data Sheet

Page	Subjects (major changes since last revision)
All	Converted to Infineon layout
2	ROM derivatives removed, 25-MHz derivatives and 3 V derivatives included
6ff	Pin numbers for TQFP added
14	Address window arbitration and master/slave mode introduced
32	New standard layout for section “Absolute Maximum Ratings”
33	Section “Operating Conditions” added
34f	Parameter “ $\overline{\text{RSTIN}}$ pullup” replaced by “ $\overline{\text{RSTIN}}$ current”
36f	DC Characteristics for reduced supply voltage added
38f	Separate specification for power consumption with greatly improved values
40ff	Description of clock generation improved
45 , 55 , 65	Timing adapted to 25 MHz
48 , 58 , 66	Timing for reduced supply voltage added

We Listen to Your Comments

Any information within this document that you feel is wrong, unclear or missing at all?
 Your feedback will help us to continuously improve the quality of this document.
 Please send your proposal (including a reference to this document) to:

mcdocu.comments@infineon.com



Pin Configuration TQFP Package (top view)

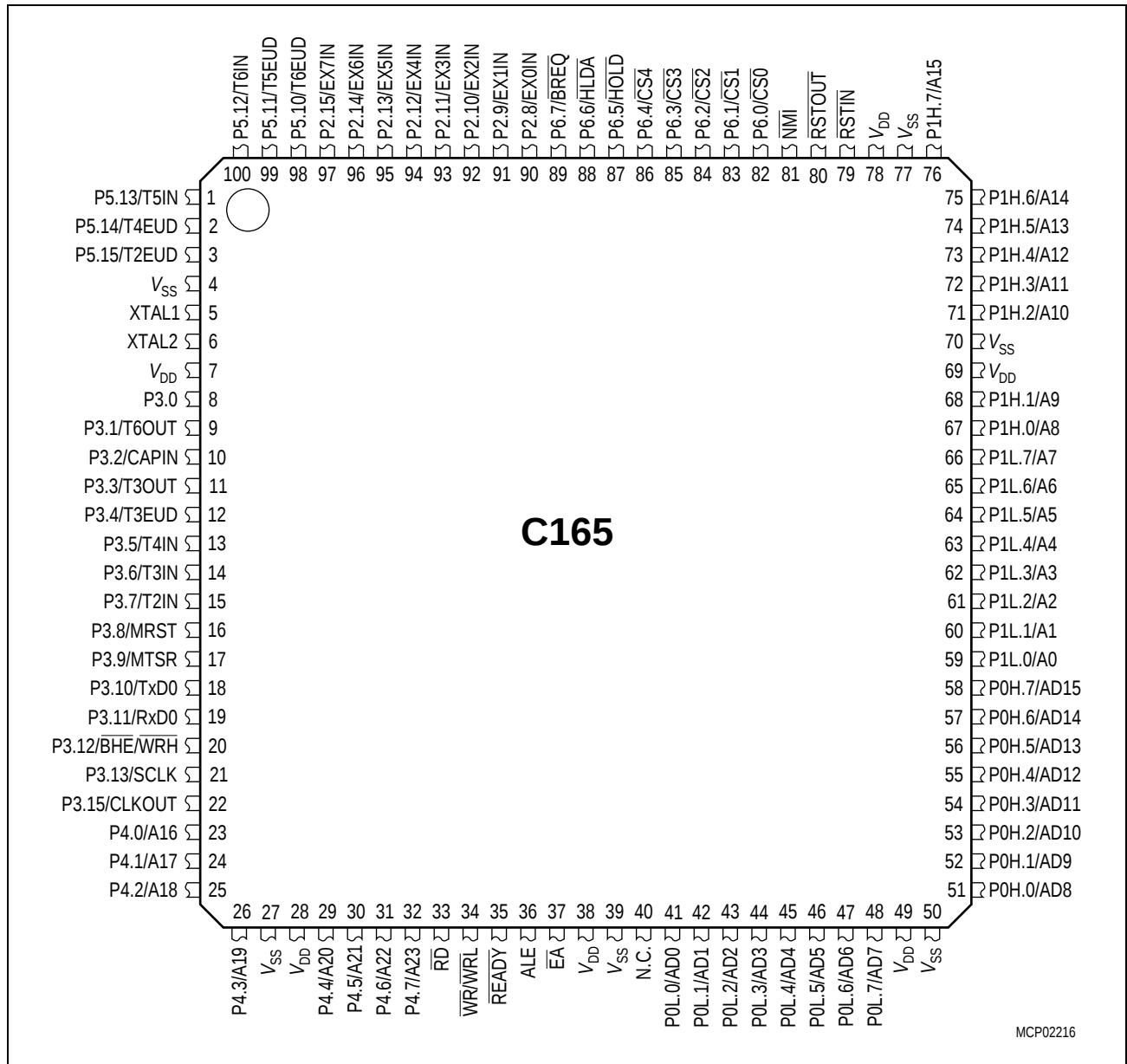


Figure 2

Pin Configuration MQFP Package (top view)

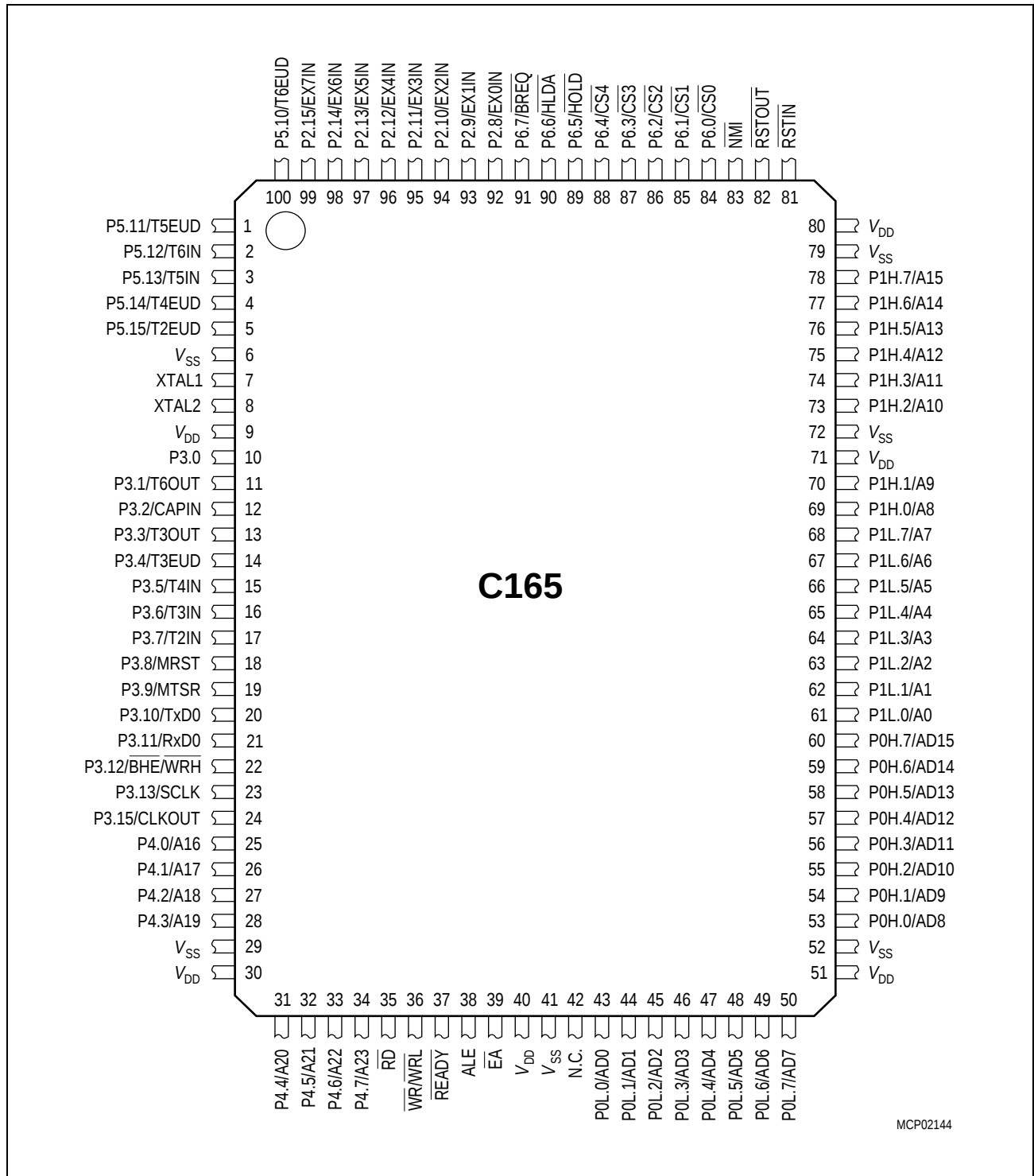


Figure 3

Table 2 Pin Definitions and Functions (cont'd)

Symbol	Pin Nr TQFP	Pin Nr MQFP	Input Outp.	Function
$\overline{\text{RSTIN}}$	79	81	I/O	Reset Input with Schmitt-Trigger characteristics. A low level at this pin while the oscillator is running resets the C165. An internal pullup resistor permits power-on reset using only a capacitor connected to V_{SS}. A spike filter suppresses input pulses < 10 ns. Input pulses >100 ns safely pass the filter. The minimum duration for a safe recognition should be 100 ns + 2 CPU clock cycles. In bidirectional reset mode (enabled by setting bit BDRSTEN in register SYSCON) the $\overline{\text{RSTIN}}$ line is internally pulled low for the duration of the internal reset sequence upon any reset (HW, SW, WDT). See note below this table. <i>Note: To let the reset configuration of PORT0 settle a reset duration of ca. 1 ms is recommended.</i>
$\overline{\text{RSTOUT}}$	80	82	O	Internal Reset Indication Output. This pin is set to a low level when the part is executing either a hardware-, a software- or a watchdog timer reset. $\overline{\text{RSTOUT}}$ remains low until the EINIT (end of initialization) instruction is executed.
$\overline{\text{NMI}}$	81	83	I	Non-Maskable Interrupt Input. A high to low transition at this pin causes the CPU to vector to the NMI trap routine. When the PWRDN (power down) instruction is executed, the $\overline{\text{NMI}}$ pin must be low in order to force the C165 to go into power down mode. If $\overline{\text{NMI}}$ is high, when PWRDN is executed, the part will continue to run in normal mode. If not used, pin $\overline{\text{NMI}}$ should be pulled high externally.

Memory Organization

The memory space of the C165 is configured in a Von Neumann architecture which means that code memory, data memory, registers and I/O ports are organized within the same linear address space which includes 16 MBytes. The entire memory space can be accessed byte-wise or word-wise. Particular portions of the on-chip memory have additionally been made directly bit-addressable.

The C165 is prepared to incorporate on-chip program memory (not in the ROM-less derivatives, of course) for code or constant data. The internal ROM area can be mapped either to segment 0 or segment 1.

2 KBytes of on-chip Internal RAM (IRAM) are provided as a storage for user defined variables, for the system stack, general purpose register banks and even for code. A register bank can consist of up to 16 word-wide (R0 to R15) and/or byte-wide (RL0, RH0, ..., RL7, RH7) so-called General Purpose Registers (GPRs).

1024 bytes (2×512 bytes) of the address space are reserved for the Special Function Register areas (SFR space and ESFR space). SFRs are word-wide registers which are used for controlling and monitoring functions of the different on-chip units. Unused SFR addresses are reserved for future members of the C166 Family.

In order to meet the needs of designs where more memory is required than is provided on chip, up to 16 MBytes of external RAM and/or ROM can be connected to the microcontroller.

Serial Channels

Serial communication with other microcontrollers, processors, terminals or external peripheral components is provided by two serial interfaces with different functionality, an Asynchronous/Synchronous Serial Channel (**ASC0**) and a High-Speed Synchronous Serial Channel (**SSC**).

The ASC0 is upward compatible with the serial ports of the Infineon 8-bit microcontroller families and supports full-duplex asynchronous communication at up to 781 KBaud and half-duplex synchronous communication at up to 3.1 MBaud (@ 25 MHz CPU clock).

A dedicated baud rate generator allows to set up all standard baud rates without oscillator tuning. For transmission, reception and error handling 4 separate interrupt vectors are provided. In asynchronous mode, 8- or 9-bit data frames are transmitted or received, preceded by a start bit and terminated by one or two stop bits. For multiprocessor communication, a mechanism to distinguish address from data bytes has been included (8-bit data plus wake up bit mode).

In synchronous mode, the ASC0 transmits or receives bytes (8 bits) synchronously to a shift clock which is generated by the ASC0. The ASC0 always shifts the LSB first. A loop back option is available for testing purposes.

A number of optional hardware error detection capabilities has been included to increase the reliability of data transfers. A parity bit can automatically be generated on transmission or be checked on reception. Framing error detection allows to recognize data frames with missing stop bits. An overrun error will be generated, if the last character received has not been read out of the receive buffer register at the time the reception of a new character is complete.

The SSC supports full-duplex synchronous communication at up to 6.25 MBaud (@ 25 MHz CPU clock). It may be configured so it interfaces with serially linked peripheral components. A dedicated baud rate generator allows to set up all standard baud rates without oscillator tuning. For transmission, reception, and error handling three separate interrupt vectors are provided.

The SSC transmits or receives characters of 2 ... 16 bits length synchronously to a shift clock which can be generated by the SSC (master mode) or by an external master (slave mode). The SSC can start shifting with the LSB or with the MSB and allows the selection of shifting and latching clock edges as well as the clock polarity.

A number of optional hardware error detection capabilities has been included to increase the reliability of data transfers. Transmit and receive error supervise the correct handling of the data buffer. Phase and baudrate error detect incorrect serial data.

Watchdog Timer

The Watchdog Timer represents one of the fail-safe mechanisms which have been implemented to prevent the controller from malfunctioning for longer periods of time.

The Watchdog Timer is always enabled after a reset of the chip, and can only be disabled in the time interval until the EINIT (end of initialization) instruction has been executed. Thus, the chip's start-up procedure is always monitored. The software has to be designed to service the Watchdog Timer before it overflows. If, due to hardware or software related failures, the software fails to do so, the Watchdog Timer overflows and generates an internal hardware reset and pulls the $\overline{\text{RSTOUT}}$ pin low in order to allow external hardware components to be reset.

The Watchdog Timer is a 16-bit timer, clocked with the system clock divided by 2/128. The high byte of the Watchdog Timer register can be set to a prespecified reload value (stored in WDTREL) in order to allow further variation of the monitored time interval. Each time it is serviced by the application software, the high byte of the Watchdog Timer is reloaded. Thus, time intervals between 20 μs and 336 ms can be monitored (@ 25 MHz).

The default Watchdog Timer interval after reset is 5.24 ms (@ 25 MHz).

Parallel Ports

The C165 provides up to 77 I/O lines which are organized into six input/output ports and one input port. All port lines are bit-addressable, and all input/output lines are individually (bit-wise) programmable as inputs or outputs via direction registers. The I/O ports are true bidirectional ports which are switched to high impedance state when configured as inputs. The output drivers of three I/O ports can be configured (pin by pin) for push/pull operation or open-drain operation via control registers. During the internal reset, all port pins are configured as inputs.

All port lines have programmable alternate input or output functions associated with them. All port lines that are not used for these alternate functions may be used as general purpose IO lines.

PORT0 and PORT1 may be used as address and data lines when accessing external memory, while Port 4 outputs the additional segment address bits A23/19/17 ... A16 in systems where segmentation is enabled to access more than 64 KBytes of memory.

Port 6 provides optional chip select signals.

Port 3 includes alternate functions of timers, serial interfaces, the optional bus control signal $\overline{\text{BHE}}/\overline{\text{WRH}}$, and the system clock output CLKOUT.

Port 5 is used for timer control signals.

Table 6 C165 Registers, Ordered by Name (cont'd)

Name		Physical Address	8-Bit Addr.	Description	Reset Value
P1H	b	FF06 _H	83 _H	Port 1 High Reg. (Upper half of PORT1)	00 _H
P1L	b	FF04 _H	82 _H	Port 1 Low Reg.(Lower half of PORT1)	00 _H
P2	b	FFC0 _H	E0 _H	Port 2 Register	0000 _H
P3	b	FFC4 _H	E2 _H	Port 3 Register	0000 _H
P4	b	FFC8 _H	E4 _H	Port 4 Register (8 bits)	00 _H
P5	b	FFA2 _H	D1 _H	Port 5 Register (read only)	XXXX _H
P6	b	FFCC _H	E6 _H	Port 6 Register (8 bits)	00 _H
PECC0		FEC0 _H	60 _H	PEC Channel 0 Control Register	0000 _H
PECC1		FEC2 _H	61 _H	PEC Channel 1 Control Register	0000 _H
PECC2		FEC4 _H	62 _H	PEC Channel 2 Control Register	0000 _H
PECC3		FEC6 _H	63 _H	PEC Channel 3 Control Register	0000 _H
PECC4		FEC8 _H	64 _H	PEC Channel 4 Control Register	0000 _H
PECC5		FECA _H	65 _H	PEC Channel 5 Control Register	0000 _H
PECC6		FECC _H	66 _H	PEC Channel 6 Control Register	0000 _H
PECC7		FECE _H	67 _H	PEC Channel 7 Control Register	0000 _H
PSW	b	FF10 _H	88 _H	CPU Program Status Word	0000 _H
RP0H	b	F108 _H	E 84 _H	System Startup Config. Reg. (Rd. only)	XX _H
S0BG		FEB4 _H	5A _H	Serial Channel 0 Baud Rate Generator Reload Register	0000 _H
S0CON	b	FFB0 _H	D8 _H	Serial Channel 0 Control Register	0000 _H
S0EIC	b	FF70 _H	B8 _H	Serial Channel 0 Error Interrupt Ctrl. Reg	0000 _H
S0RBUF		FEB2 _H	59 _H	Serial Channel 0 Receive Buffer Reg. (read only)	XX _H
S0RIC	b	FF6E _H	B7 _H	Serial Channel 0 Receive Interrupt Control Register	0000 _H
S0TBIC	b	F19C _H	E CE _H	Serial Channel 0 Transmit Buffer Interrupt Control Register	0000 _H
S0TBUF		FEB0 _H	58 _H	Serial Channel 0 Transmit Buffer Register (write only)	00 _H
S0TIC	b	FF6C _H	B6 _H	Serial Channel 0 Transmit Interrupt Control Register	0000 _H

Operating Conditions

The following operating conditions must not be exceeded in order to ensure correct operation of the C165. All parameters specified in the following sections refer to these operating conditions, unless otherwise noticed.

Table 8 Operating Condition Parameters

Parameter	Symbol	Limit Values		Unit	Notes
		min.	max.		
Standard digital supply voltage (5 V versions)	V_{DD}	4.5	5.5	V	Active mode, $f_{CPUmax} = 25$ MHz
		2.5 ¹⁾	5.5	V	PowerDown mode
Reduced digital supply voltage (3 V versions)	V_{DD}	3.0	3.6	V	Active mode, $f_{CPUmax} = 20$ MHz
		2.5 ¹⁾	3.6	V	PowerDown mode
Digital ground voltage	V_{SS}	0		V	Reference voltage
Overload current	I_{OV}	–	± 5	mA	Per pin ²⁾³⁾
Absolute sum of overload currents	$\Sigma I_{OV} $	–	50	mA	³⁾
External Load Capacitance	C_L	–	100	pF	–
Ambient temperature	T_A	0	70	°C	SAB-C165 ...
		- 40	85	°C	SAF-C165 ...
		- 40	125	°C	SAK-C165 ...

¹⁾ Output voltages and output currents will be reduced when V_{DD} leaves the range defined for active mode.

²⁾ Overload conditions occur if the standard operating conditions are exceeded, i.e. the voltage on any pin exceeds the specified range (i.e. $V_{OV} > V_{DD} + 0.5$ V or $V_{OV} < V_{SS} - 0.5$ V). The absolute sum of input overload currents on all pins may not exceed **50 mA**. The supply voltage must remain within the specified limits. Proper operation is not guaranteed if overload conditions occur on functional pins such as XTAL1, $\overline{RD}$, $\overline{WR}$, etc.

³⁾ Not 100% tested, guaranteed by design and characterization.

DC Characteristics (Standard Supply Voltage Range) (cont'd)

(Operating Conditions apply)¹⁾

Parameter	Symbol	Limit Values		Unit	Test Condition
		min.	max.		
$\overline{\text{RSTIN}}$ active current ⁴⁾	I_{RSTL} ⁶⁾	- 100	–	μA	$V_{\text{IN}} = V_{\text{IL}}$
$\overline{\text{READY}}/\overline{\text{RD}}/\overline{\text{WR}}$ inact. current ⁷⁾	I_{RWH} ⁵⁾	–	- 40	μA	$V_{\text{OUT}} = 2.4 \text{ V}$
$\overline{\text{READY}}/\overline{\text{RD}}/\overline{\text{WR}}$ active current ⁷⁾	I_{RWL} ⁶⁾	- 500	–	μA	$V_{\text{OUT}} = V_{\text{OLmax}}$
ALE inactive current ⁷⁾	I_{ALEL} ⁵⁾	–	40	μA	$V_{\text{OUT}} = V_{\text{OLmax}}$
ALE active current ⁷⁾	I_{ALEH} ⁶⁾	500	–	μA	$V_{\text{OUT}} = 2.4 \text{ V}$
Port 6 inactive current ⁷⁾	I_{P6H} ⁵⁾	–	- 40	μA	$V_{\text{OUT}} = 2.4 \text{ V}$
Port 6 active current ⁷⁾	I_{P6L} ⁶⁾	- 500	–	μA	$V_{\text{OUT}} = V_{\text{OL1max}}$
PORT0 configuration current ⁸⁾	I_{P0H} ⁵⁾	–	- 10	μA	$V_{\text{IN}} = V_{\text{IHmin}}$
	I_{P0L} ⁶⁾	- 100	–	μA	$V_{\text{IN}} = V_{\text{ILmax}}$
XTAL1 input current	I_{IL} CC	–	± 20	μA	$0 \text{ V} < V_{\text{IN}} < V_{\text{DD}}$
Pin capacitance ⁹⁾ (digital inputs/outputs)	C_{IO} CC	–	10	pF	$f = 1 \text{ MHz}$ $T_{\text{A}} = 25 \text{ }^{\circ}\text{C}$

¹⁾ Keeping signal levels within the levels specified in this table, ensures operation without overload conditions. For signal levels outside these specifications also refer to the specification of the overload current I_{OV} .

²⁾ Valid in bidirectional reset mode only.

³⁾ This specification is not valid for outputs which are switched to open drain mode. In this case the respective output will float and the voltage results from the external circuitry.

⁴⁾ These parameters describe the $\overline{\text{RSTIN}}$ pullup, which equals a resistance of ca. 50 to 250 k Ω .

⁵⁾ The maximum current may be drawn while the respective signal line remains inactive.

⁶⁾ The minimum current must be drawn in order to drive the respective signal line active.

⁷⁾ This specification is valid during Reset and during Hold-mode or Adapt-mode. During Hold-mode Port 6 pins are only affected, if they are used (configured) for $\overline{\text{CS}}$ output and the open drain function is not enabled. The $\overline{\text{READY}}$ -pullup is always active, except for Powerdown mode.

⁸⁾ This specification is valid during Reset and during Adapt-mode.

⁹⁾ Not 100% tested, guaranteed by design and characterization.

DC Characteristics (Reduced Supply Voltage Range) (cont'd)

(Operating Conditions apply)¹⁾

Parameter	Symbol	Limit Values		Unit	Test Condition
		min.	max.		
PORT0 configuration current ⁸⁾	I_{P0H} ⁵⁾	–	- 5	μA	$V_{IN} = V_{IHmin}$
	I_{P0L} ⁶⁾	- 100	–	μA	$V_{IN} = V_{ILmax}$
XTAL1 input current	I_{IL} CC	–	± 20	μA	$0\text{ V} < V_{IN} < V_{DD}$
Pin capacitance ⁹⁾ (digital inputs/outputs)	C_{IO} CC	–	10	pF	$f = 1\text{ MHz}$ $T_A = 25\text{ °C}$

¹⁾ Keeping signal levels within the levels specified in this table, ensures operation without overload conditions. For signal levels outside these specifications also refer to the specification of the overload current I_{OV} .

²⁾ Valid in bidirectional reset mode only.

³⁾ This specification is not valid for outputs which are switched to open drain mode. In this case the respective output will float and the voltage results from the external circuitry.

⁴⁾ These parameters describe the $\overline{RSTIN}$ pullup, which equals a resistance of ca. 50 to 250 kΩ.

⁵⁾ The maximum current may be drawn while the respective signal line remains inactive.

⁶⁾ The minimum current must be drawn in order to drive the respective signal line active.

⁷⁾ This specification is valid during Reset and during Hold-mode or Adapt-mode. During Hold-mode Port 6 pins are only affected, if they are used (configured) for $\overline{CS}$ output and the open drain function is not enabled. The $\overline{READY}$ -pullup is always active, except for Powerdown mode.

⁸⁾ This specification is valid during Reset and during Adapt-mode.

⁹⁾ Not 100% tested, guaranteed by design and characterization.

AC Characteristics

Table 10 External Clock Drive XTAL1 (Standard Supply Voltage Range)
(Operating Conditions apply)

Parameter	Symbol		Direct Drive 1:1		Prescaler 2:1		Unit
			min.	max.	min.	max.	
Oscillator period	t_{OSC}	SR	40	–	20	–	ns
High time ¹⁾	t_1	SR	20 ²⁾	–	6	–	ns
Low time ¹⁾	t_2	SR	20 ²⁾	–	6	–	ns
Rise time ¹⁾	t_3	SR	–	10	–	6	ns
Fall time ¹⁾	t_4	SR	–	10	–	6	ns

¹⁾ The clock input signal must reach the defined levels V_{IL2} and V_{IH2} .

²⁾ The minimum high and low time refers to a duty cycle of 50%. The maximum operating frequency (f_{CPU}) in direct drive mode depends on the duty cycle of the clock input signal.

Table 11 External Clock Drive XTAL1 (Reduced Supply Voltage Range)
(Operating Conditions apply)

Parameter	Symbol		Direct Drive 1:1		Prescaler 2:1		Unit
			min.	max.	min.	max.	
Oscillator period	t_{OSC}	SR	50	–	25	–	ns
High time ¹⁾	t_1	SR	25 ²⁾	–	8	–	ns
Low time ¹⁾	t_2	SR	25 ²⁾	–	8	–	ns
Rise time ¹⁾	t_3	SR	–	10	–	6	ns
Fall time ¹⁾	t_4	SR	–	10	–	6	ns

¹⁾ The clock input signal must reach the defined levels V_{IL2} and V_{IH2} .

²⁾ The minimum high and low time refers to a duty cycle of 50%. The maximum operating frequency (f_{CPU}) in direct drive mode depends on the duty cycle of the clock input signal.

AC Characteristics

Multiplexed Bus (Reduced Supply Voltage Range)

(Operating Conditions apply)

ALE cycle time = $6 \text{ TCL} + 2t_A + t_C + t_F$ (150 ns at 20 MHz CPU clock without waitstates)

Parameter	Symbol	Max. CPU Clock = 20 MHz		Variable CPU Clock 1 / 2TCL = 1 to 20 MHz		Unit
		min.	max.	min.	max.	
ALE high time	t_5 CC	$11 + t_A$	–	$\text{TCL} - 14 + t_A$	–	ns
Address setup to ALE	t_6 CC	$5 + t_A$	–	$\text{TCL} - 20 + t_A$	–	ns
Address hold after ALE	t_7 CC	$15 + t_A$	–	$\text{TCL} - 10 + t_A$	–	ns
ALE falling edge to $\overline{\text{RD}}$, $\overline{\text{WR}}$ (with RW-delay)	t_8 CC	$15 + t_A$	–	$\text{TCL} - 10 + t_A$	–	ns
ALE falling edge to $\overline{\text{RD}}$, $\overline{\text{WR}}$ (no RW-delay)	t_9 CC	$-10 + t_A$	–	$-10 + t_A$	–	ns
Address float after $\overline{\text{RD}}$, $\overline{\text{WR}}$ (with RW-delay)	t_{10} CC	–	6	–	6	ns
Address float after $\overline{\text{RD}}$, $\overline{\text{WR}}$ (no RW-delay)	t_{11} CC	–	31	–	$\text{TCL} + 6$	ns
$\overline{\text{RD}}$, $\overline{\text{WR}}$ low time (with RW-delay)	t_{12} CC	$34 + t_C$	–	$2\text{TCL} - 16 + t_C$	–	ns
$\overline{\text{RD}}$, $\overline{\text{WR}}$ low time (no RW-delay)	t_{13} CC	$59 + t_C$	–	$3\text{TCL} - 16 + t_C$	–	ns
$\overline{\text{RD}}$ to valid data in (with RW-delay)	t_{14} SR	–	$22 + t_C$	–	$2\text{TCL} - 28 + t_C$	ns
$\overline{\text{RD}}$ to valid data in (no RW-delay)	t_{15} SR	–	$47 + t_C$	–	$3\text{TCL} - 28 + t_C$	ns
ALE low to valid data in	t_{16} SR	–	$45 + t_A + t_C$	–	$3\text{TCL} - 30 + t_A + t_C$	ns
Address to valid data in	t_{17} SR	–	$57 + 2t_A + t_C$	–	$4\text{TCL} - 43 + 2t_A + t_C$	ns
Data hold after $\overline{\text{RD}}$ rising edge	t_{18} SR	0	–	0	–	ns

Multiplexed Bus (Reduced Supply Voltage Range) (cont'd)

(Operating Conditions apply)

ALE cycle time = $6 \text{ TCL} + 2t_A + t_C + t_F$ (150 ns at 20 MHz CPU clock without waitstates)

Parameter	Symbol	Max. CPU Clock = 20 MHz		Variable CPU Clock 1 / 2TCL = 1 to 20 MHz		Unit
		min.	max.	min.	max.	
Data valid to $\overline{\text{WrCS}}$	t_{50} CC	$28 + t_C$	–	$2\text{TCL} - 22 + t_C$	–	ns
Data hold after $\overline{\text{RdCS}}$	t_{51} SR	0	–	0	–	ns
Data float after $\overline{\text{RdCS}}$	t_{52} SR	–	$30 + t_F$	–	$2\text{TCL} - 20 + t_F$	ns
Address hold after $\overline{\text{RdCS}}, \overline{\text{WrCS}}$	t_{54} CC	$30 + t_F$	–	$2\text{TCL} - 20 + t_F$	–	ns
Data hold after $\overline{\text{WrCS}}$	t_{56} CC	$30 + t_F$	–	$2\text{TCL} - 20 + t_F$	–	ns

- ¹⁾ These parameters refer to the latched chip select signals ($\overline{\text{CSxL}}$). The early chip select signals ($\overline{\text{CSxE}}$) are specified together with the address and signal $\overline{\text{BHE}}$ (see figures below).

Demultiplexed Bus (Reduced Supply Voltage Range) (cont'd)

(Operating Conditions apply)

ALE cycle time = $4 \text{ TCL} + 2t_A + t_C + t_F$ (100 ns at 20 MHz CPU clock without waitstates)

Parameter	Symbol	Max. CPU Clock = 20 MHz		Variable CPU Clock 1 / 2TCL = 1 to 20 MHz		Unit
		min.	max.	min.	max.	
Data valid to $\overline{\text{WR}}$	t_{22} CC	$24 + t_C$	–	$2\text{TCL} - 26 + t_C$	–	ns
Data hold after $\overline{\text{WR}}$	t_{24} CC	$15 + t_F$	–	$\text{TCL} - 10 + t_F$	–	ns
ALE rising edge after $\overline{\text{RD}}, \overline{\text{WR}}$	t_{26} CC	$-12 + t_F$	–	$-12 + t_F$	–	ns
Address hold after $\overline{\text{WR}}^{(2)}$	t_{28} CC	$0 + t_F$	–	$0 + t_F$	–	ns
ALE falling edge to $\overline{\text{CS}}^{(3)}$	t_{38} CC	$-8 - t_A$	$10 - t_A$	$-8 - t_A$	$10 - t_A$	ns
$\overline{\text{CS}}$ low to Valid Data In ⁽³⁾	t_{39} SR	–	$47 + t_C + 2t_A$	–	$3\text{TCL} - 28 + t_C + 2t_A$	ns
$\overline{\text{CS}}$ hold after $\overline{\text{RD}}, \overline{\text{WR}}^{(3)}$	t_{41} CC	$9 + t_F$	–	$\text{TCL} - 16 + t_F$	–	ns
ALE falling edge to $\overline{\text{RdCS}}, \overline{\text{WrCS}}$ (with RW-delay)	t_{42} CC	$19 + t_A$	–	$\text{TCL} - 6 + t_A$	–	ns
ALE falling edge to $\overline{\text{RdCS}}, \overline{\text{WrCS}}$ (no RW-delay)	t_{43} CC	$-6 + t_A$	–	$-6 + t_A$	–	ns
$\overline{\text{RdCS}}$ to Valid Data In (with RW-delay)	t_{46} SR	–	$20 + t_C$	–	$2\text{TCL} - 30 + t_C$	ns
$\overline{\text{RdCS}}$ to Valid Data In (no RW-delay)	t_{47} SR	–	$45 + t_C$	–	$3\text{TCL} - 30 + t_C$	ns
$\overline{\text{RdCS}}, \overline{\text{WrCS}}$ Low Time (with RW-delay)	t_{48} CC	$38 + t_C$	–	$2\text{TCL} - 12 + t_C$	–	ns
$\overline{\text{RdCS}}, \overline{\text{WrCS}}$ Low Time (no RW-delay)	t_{49} CC	$63 + t_C$	–	$3\text{TCL} - 12 + t_C$	–	ns
Data valid to $\overline{\text{WrCS}}$	t_{50} CC	$28 + t_C$	–	$2\text{TCL} - 22 + t_C$	–	ns
Data hold after $\overline{\text{RdCS}}$	t_{51} SR	0	–	0	–	ns

Demultiplexed Bus (Reduced Supply Voltage Range) (cont'd)

(Operating Conditions apply)

ALE cycle time = $4 \text{ TCL} + 2t_A + t_C + t_F$ (100 ns at 20 MHz CPU clock without waitstates)

Parameter	Symbol	Max. CPU Clock = 20 MHz		Variable CPU Clock 1 / 2TCL = 1 to 20 MHz		Unit
		min.	max.	min.	max.	
Data float after $\overline{\text{RdCS}}$ (with RW-delay) ¹⁾	t_{53} SR	–	$30 + t_F$	–	$2\text{TCL} - 20 + 2t_A + t_F$ 1)	ns
Data float after $\overline{\text{RdCS}}$ (no RW-delay) ¹⁾	t_{68} SR	–	$5 + t_F$	–	$\text{TCL} - 20 + 2t_A + t_F$ 1)	ns
Address hold after $\overline{\text{RdCS}}$, $\overline{\text{WrCS}}$	t_{55} CC	$-16 + t_F$	–	$-16 + t_F$	–	ns
Data hold after $\overline{\text{WrCS}}$	t_{57} CC	$9 + t_F$	–	$\text{TCL} - 16 + t_F$	–	ns

¹⁾ RW-delay and t_A refer to the next following bus cycle (including an access to an on-chip X-Peripheral).

²⁾ Read data are latched with the same clock edge that triggers the address change and the rising $\overline{\text{RD}}$ edge. Therefore address changes before the end of $\overline{\text{RD}}$ have no impact on read cycles.

³⁾ These parameters refer to the latched chip select signals ($\overline{\text{CSxL}}$). The early chip select signals ($\overline{\text{CSxE}}$) are specified together with the address and signal $\overline{\text{BHE}}$ (see figures below).

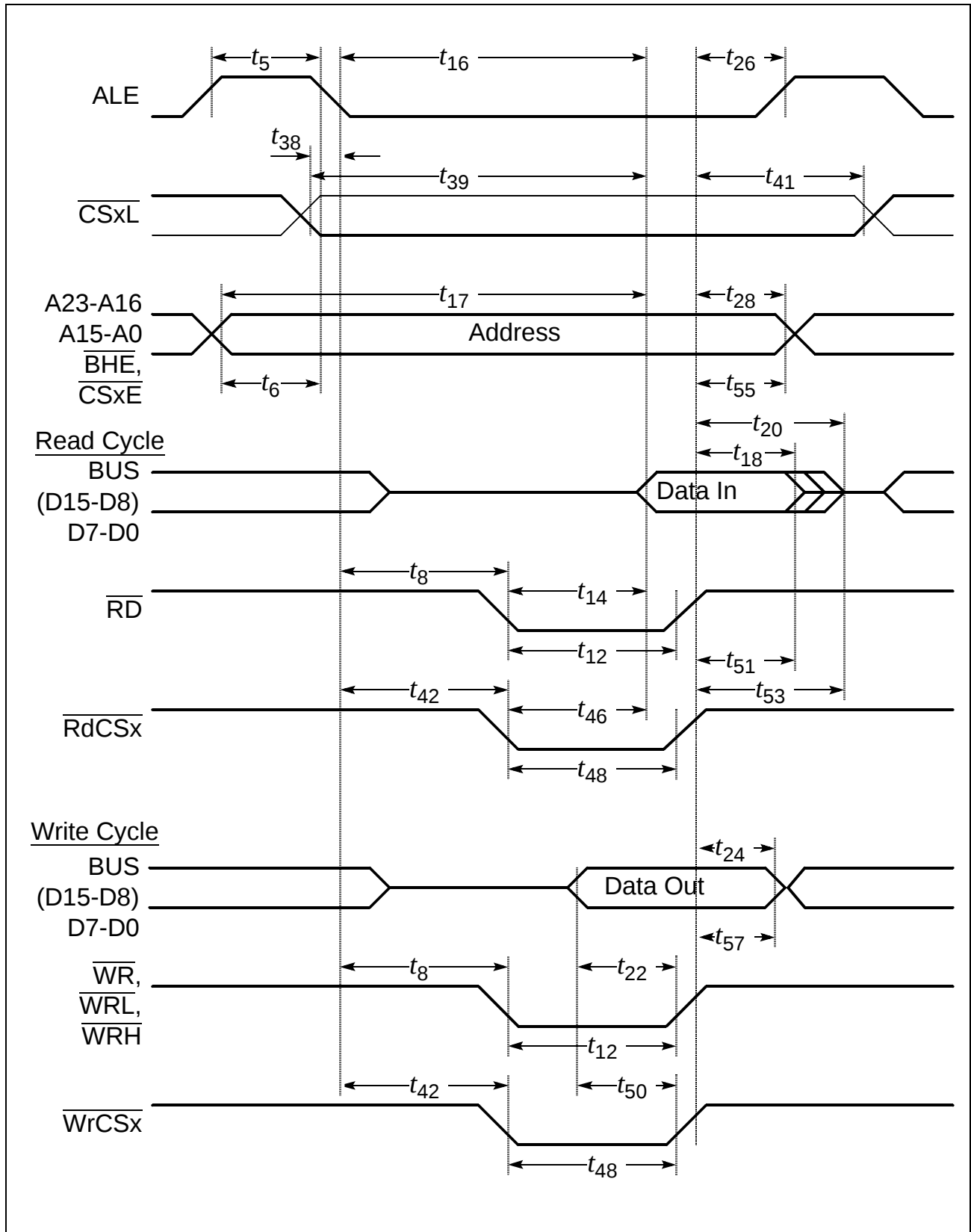


Figure 18 External Memory Cycle:
Demultiplexed Bus, With Read/Write Delay, Extended ALE

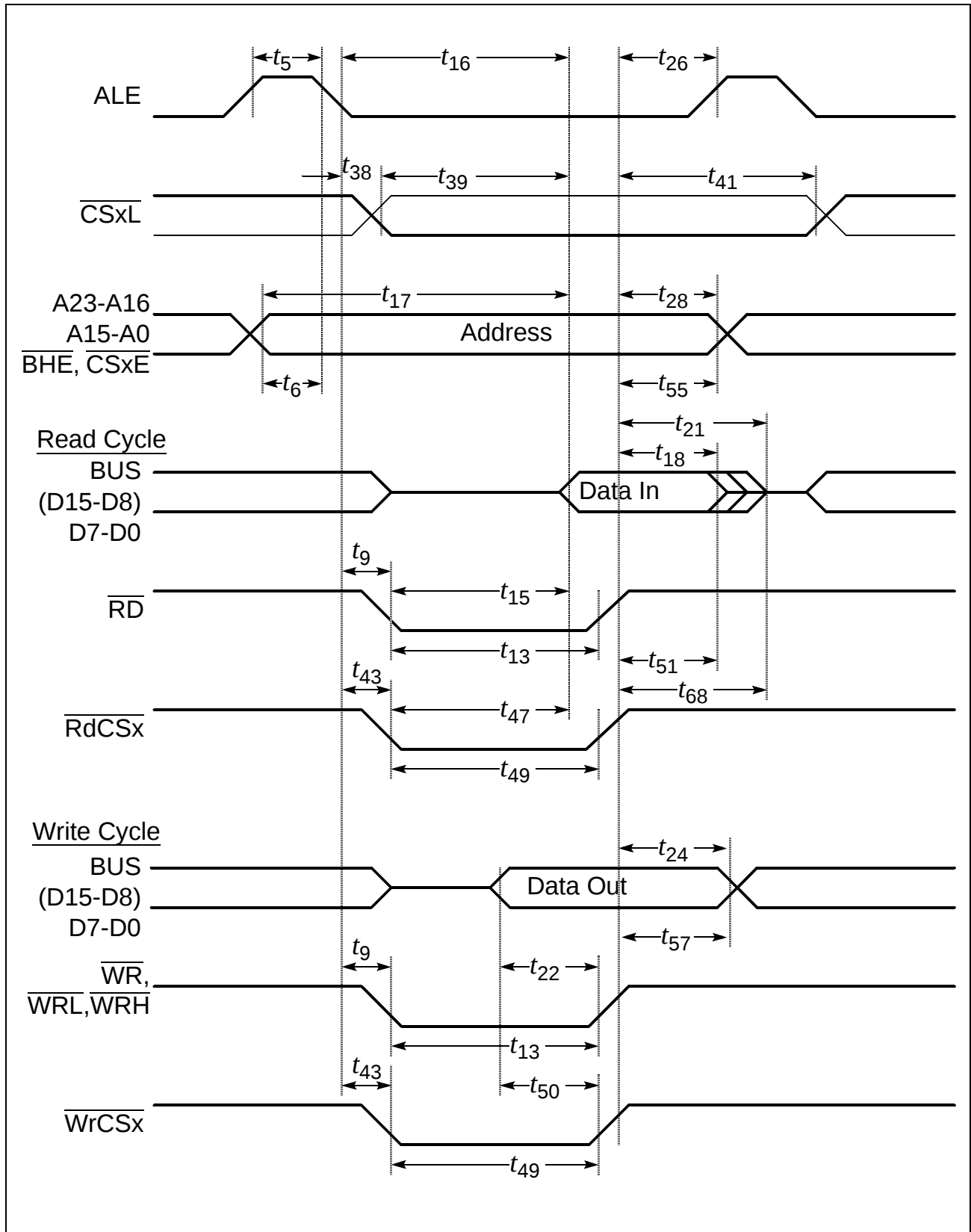


Figure 19 External Memory Cycle:
Demultiplexed Bus, No Read/Write Delay, Normal ALE

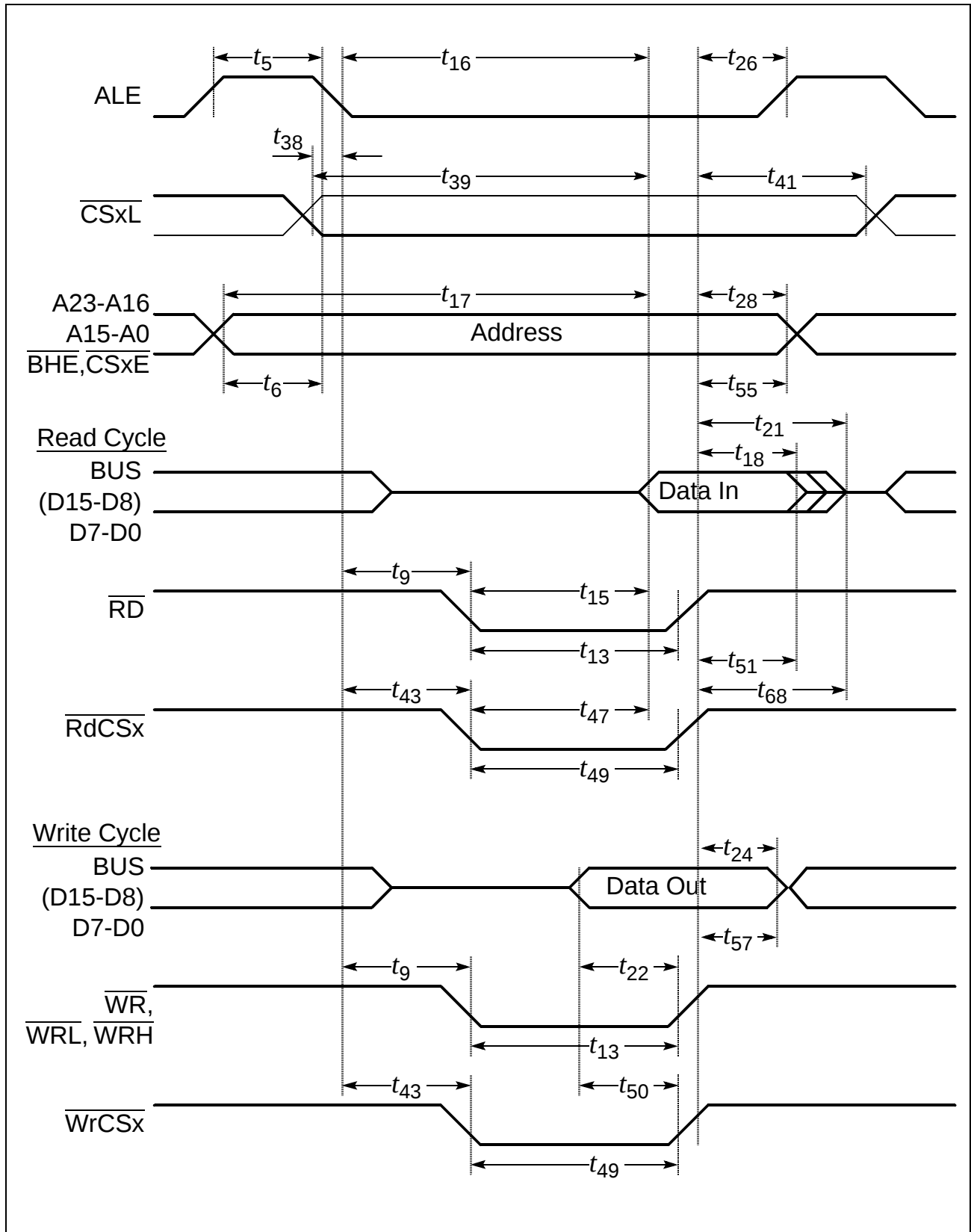


Figure 20 External Memory Cycle:
Demultiplexed Bus, No Read/Write Delay, Extended ALE

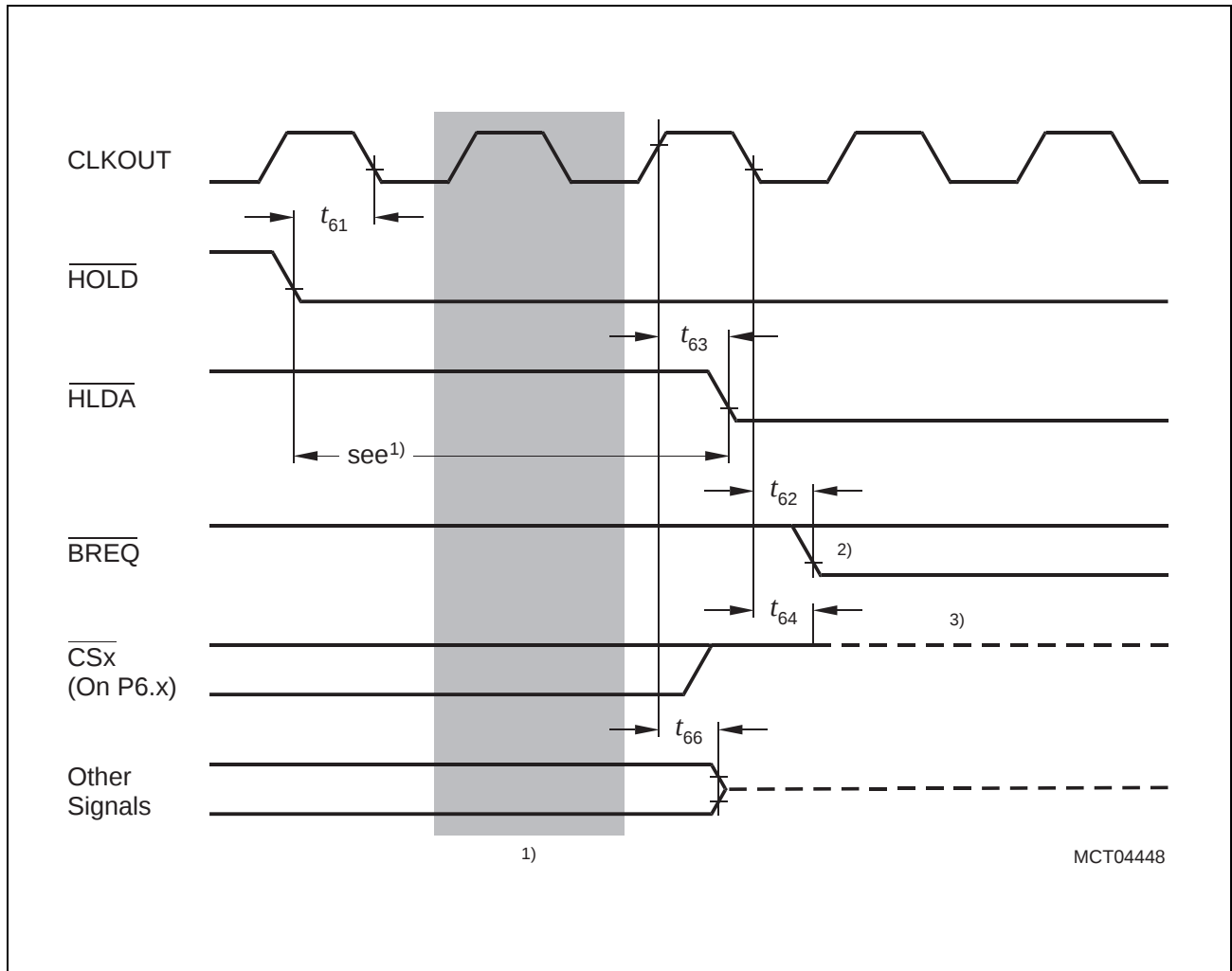


Figure 22 External Bus Arbitration, Releasing the Bus

Notes

- 1) The C165 will complete the currently running bus cycle before granting bus access.
- 2) This is the first possibility for $\overline{\text{BREQ}}$ to get active.
- 3) The $\overline{\text{CS}}$ outputs will be resistive high (pullup) after t_{64} .